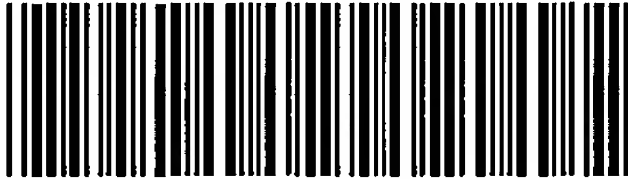


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/628,256	CHEN, TAILEE	
	Examiner	Art Unit	
	Shih-Chao Chen	2821	

SEARCHED			
Class	Subclass	Date	Examiner
343	700MS, 793, 795, 810	2/2/2005	CHEN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
343	700MS	2/2/2005	CHEN
343	795	2/2/2005	CHEN

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	2/2/2005	CHEN